













CSD18533KCS

SLPS362C - SEPTEMBER 2012-REVISED JUNE 2015

CSD18533KCS 60 V N-Channel NexFET™ Power MOSFET

Features

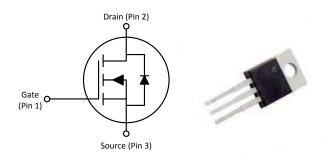
- Ultra-Low Qa and Qad
- Low Thermal Resistance
- Avalanche Rated
- Logic Level
- Pb-Free Terminal Plating
- **RoHS Compliant**
- Halogen Free
- TO-220 Plastic Package

Applications

- DC-DC Conversion
- Secondary Side Synchronous Rectifier
- Motor Control

3 Description

This 5.0 m Ω , 60 V TO-220 NexFETTM power MOSFET is designed to minimize losses in power conversion applications.



Product Summary

T _A = 25°	С	TYPICAL VA	UNIT	
V_{DS}	Drain-to-source voltage	60	٧	
Q_g	Gate charge total (10 V)	28		nC
Q_{gd}	Gate charge gate-to-drain	3.9	nC	
В	Drain-to-source on-resistance	$V_{GS} = 4.5 \text{ V}$	6.9	mΩ
R _{DS(on)} Drain-to-source on-resistance		V _{GS} = 10 V	5.0	mΩ
$V_{GS(th)}$	Threshold voltage	1.9		V

Ordering Information(1)

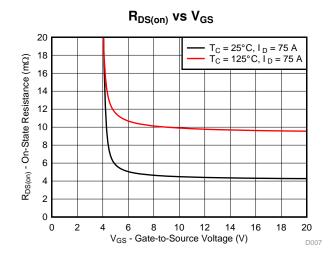
DEVICE	QTY MEDIA		PACKAGE	SHIP	
CSD18533KC	S 50	Tube	TO-220 Plastic Package	Tube	

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Absolute Maximum Ratings

Absolute Maximum Hatings								
T _A = 2	5°C	VALUE	UNIT					
V_{DS}	Drain-to-source voltage	60	V					
V_{GS}	Gate-to-source voltage	±20	٧					
	Continuous drain current (package limited)	100						
I _D	Continuous drain current (silicon limited), T _C = 25°C	118	Α					
	Continuous drain current (silicon limited), T _C = 100°C	84						
I_{DM}	Pulsed drain current (1)	294	Α					
P_D	Power dissipation	192	W					
T _J , T _{stg}	Operating junction, Storage temperature	–55 to 175	ô					
E _{AS}	Avalanche energy, single pulse I_D = 52 A, L = 0.1 mH, R_G = 25 Ω	135	mJ					

(1) Max $R_{\theta JC} = 0.8^{\circ}C/W$, pulse duration $\leq 100~\mu s$, duty cycle $\leq 1\%$



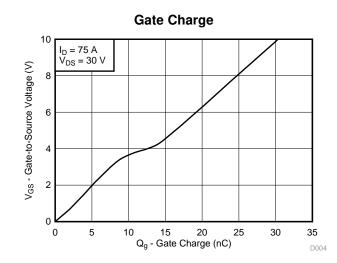




Table of Contents

1	Features 1	6	Device and Documentation Support
2	Applications 1		6.1 Community Resources
3	Description 1		6.2 Trademarks
4	Revision History2		6.3 Electrostatic Discharge Caution
	Specifications3		6.4 Glossary
	5.1 Electrical Characteristics	7	Mechanical, Packaging, and Orderable
	5.2 Thermal Information		
	5.3 Typical MOSFET Characteristics 4		7.1 KCS Package Dimensions

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision B (April 2014) to Revision C	Page
Updated Pulsed Drain Current	1
Updated pulsed current conditions	1
Updated Figure 1	
Updated SOA in Figure 10	
Added Community Resources	
Changes from Revision A (January 2013) to Revision B	Page

•	Updated document title to include part number
•	Updated part description
•	Increased currents to reflect increase in max temperature
•	Increased max power to reflect increase in max temperature
•	Increased max temperature to 175°C
•	Updated Figure 6 to extend to 175°C
•	Updated Figure 8 to extend to 175°C
•	Updated Figure 12 to extend to 175°C

CI	hanges from Original (September 2012) to Revision A	Page)
•	Changed Q _{q(th)} , Gate Charge at V _{th} value From: 7.3 To: 4.6	3	3



5 Specifications

5.1 Electrical Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

C unless otherwise stated)					
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
CHARACTERISTICS					
Drain-to-source voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60			V
Drain-to-source leakage current	$V_{GS} = 0 V, V_{DS} = 48 V$			1	μΑ
Gate-to-source leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = 20 \text{ V}$			100	nA
Gate-to-source threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1.5	1.9	2.3	V
Drain to acureo an registence	$V_{GS} = 4.5 \text{ V}, I_D = 75 \text{ A}$		6.9	9.0	mΩ
Drain-to-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 75 \text{ A}$		5.0	6.3	mΩ
Transconductance	$V_{DS} = 30 \text{ V}, I_D = 75 \text{ A}$		150		S
C CHARACTERISTICS	•	•			
Input capacitance			2420	3025	pF
Output capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 30 \text{ V}, f = 1 \text{ MHz}$		300	375	pF
Reverse transfer capacitance			7	9.1	pF
Series gate resistance			1.4	2.8	Ω
Gate charge total (4.5 V)			14	17	nC
Gate charge total (10 V)			28	34	nC
Gate charge gate-to-drain	$V_{DS} = 30 \text{ V}, I_{D} = 75 \text{ A}$		3.9		nC
Gate charge gate-to-source			9.4		nC
Gate charge at V _{th}			4.6		nC
Output charge	V _{DS} = 30 V, V _{GS} = 0 V		31		nC
Turn on delay time			5.7		ns
Rise time	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V},$		4.8		ns
Turn off delay time	$I_{DS} = 75 \text{ A}, R_G = 0 \Omega$		13		ns
Fall time			3.2		ns
HARACTERISTICS	'			 	
Diode forward voltage	I _{SD} = 75 A, V _{GS} = 0 V		0.8	1	V
Reverse recovery charge	$V_{DS} = 30 \text{ V}, I_{F} = 75 \text{ A},$		97		nC
Reverse recovery time	di/dt = 300 A/µs		49		ns
	PARAMETER CHARACTERISTICS Drain-to-source voltage Drain-to-source leakage current Gate-to-source threshold voltage Drain-to-source on-resistance Transconductance C CHARACTERISTICS Input capacitance Output capacitance Reverse transfer capacitance Series gate resistance Gate charge total (4.5 V) Gate charge gate-to-drain Gate charge at V _{th} Output charge Turn on delay time Rise time Turn off delay time Fall time HARACTERISTICS Diode forward voltage Reverse recovery charge	PARAMETER TEST CONDITIONS CHARACTERISTICS Drain-to-source voltage $V_{GS} = 0 \text{ V}, I_D = 250 \text{ μA}$ Drain-to-source leakage current $V_{GS} = 0 \text{ V}, V_{DS} = 48 \text{ V}$ Gate-to-source leakage current $V_{DS} = 0 \text{ V}, V_{DS} = 20 \text{ V}$ Gate-to-source threshold voltage $V_{DS} = V_{GS}, I_D = 250 \text{ μA}$ Drain-to-source on-resistance $V_{DS} = 4.5 \text{ V}, I_D = 75 \text{ A}$ Transconductance $V_{DS} = 30 \text{ V}, I_D = 75 \text{ A}$ C CHARACTERISTICS Input capacitance Output capacitance $V_{DS} = 30 \text{ V}, V_{DS} = 30 \text{ V}, f = 1 \text{ MHz}$ Reverse transfer capacitance $V_{CS} = 0 \text{ V}, V_{DS} = 30 \text{ V}, f = 1 \text{ MHz}$ Gate charge total (4.5 V) $V_{DS} = 30 \text{ V}, V_{DS} = 30 \text{ V}, V_{DS} = 75 \text{ A}$ Gate charge total (10 V) $V_{DS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$ Gate charge gate-to-source $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$ Gate charge at V_{th} $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$ Turn on delay time $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$ Rise time $V_{DS} = 75 \text{ A}, V_{GS} = 0 \text{ V}$ Turn off delay time $V_{DS} = 75 \text{ A}, V_{GS} = 0 \text{ V}$ HARACTERISTICS $V_{DS} = 30$	PARAMETER TEST CONDITIONS MIN CHARACTERISTICS Drain-to-source voltage V _{GS} = 0 V, I _D = 250 μA 60 Drain-to-source leakage current V _{GS} = 0 V, V _{DS} = 48 V 60 Gate-to-source leakage current V _{DS} = 0 V, V _{GS} = 20 V 1.5 Gate-to-source threshold voltage V _{DS} = V _{GS} , I _D = 250 μA 1.5 Drain-to-source on-resistance V _{DS} = 4.5 V, I _D = 75 A 75 A Transconductance V _{DS} = 30 V, I _D = 75 A 75 A C CHARACTERISTICS Input capacitance V _{GS} = 0 V, V _{DS} = 30 V, f = 1 MHz Reverse transfer capacitance V _{GS} = 0 V, V _{DS} = 30 V, f = 1 MHz Reverse transfer capacitance V _{GS} = 0 V, V _{DS} = 30 V, f = 1 MHz Gate charge total (4.5 V) Gate charge total (10 V) Gate charge gate-to-drain V _{DS} = 30 V, I _D = 75 A Gate charge gate-to-source Gate charge at V _{II} Output charge V _{DS} = 30 V, V _{GS} = 0 V Turn on delay time I _{DS} = 75 A, R _G = 0 Ω Fall time I _{DS} = 75 A, V _{GS} = 0 V HARACTERISTICS I _{DS} = 75 A, V _{GS} = 0 V Diode forward voltage I _{DS} = 75 A,	PARAMETER TEST CONDITIONS MIN TYP CHARACTERISTICS Drain-to-source voltage V _{GS} = 0 V, I _D = 250 μA 60 Drain-to-source leakage current V _{GS} = 0 V, V _{DS} = 48 V 60 Gate-to-source leakage current V _{DS} = 0 V, V _{DS} = 20 V 1.5 1.9 Gate-to-source threshold voltage V _{DS} = 250 μA 1.5 1.9 Drain-to-source on-resistance V _{GS} = 4.5 V, I _D = 75 A 6.9 6.9 V _{GS} = 10 V, I _D = 75 A 5.0 5.0 150 C CHARACTERISTICS Input capacitance 2420 150 Drutu capacitance V _{GS} = 0 V, V _{DS} = 30 V, I _D = 75 A 300 Reverse transfer capacitance 2420 7 Gate charge total (4.5 V) 14 300 Reverse gate resistance 1.4 300 Gate charge total (10 V) 28 3.9 Gate charge gate-to-drain V _{DS} = 30 V, I _D = 75 A 3.9 Gate charge at V _{th} 4.6 4.6 Output charge V _{DS} = 30 V, V _{GS} = 0 V 31 Turn on delay time	PARAMETER TEST CONDITIONS MIN TYP MAX CHARACTERISTICS Drain-to-source voltage V _{GS} = 0 V, V _{DS} = 250 μA 60 1 Drain-to-source leakage current V _{GS} = 0 V, V _{DS} = 48 V 1 1 Gate-to-source leakage current V _{DS} = 0 V, V _{GS} = 20 V 100 Gate-to-source threshold voltage V _{DS} = V _{GS} , I _D = 250 μA 1.5 1.9 2.3 Drain-to-source on-resistance V _{GS} = 4.5 V, I _D = 75 A 6.9 9.0 V _{SS} = 10 V, I _D = 75 A 5.0 6.3 Transconductance V _{DS} = 30 V, I _D = 75 A 150 C CHARACTERISTICS 2420 3025 Input capacitance V _{GS} = 0 V, V _{DS} = 30 V, I = 1 MHz 300 375 Reverse transfer capacitance 1.4 2.8 2420 3025 Series gate resistance 1.4 2.8 14 17 2.8 Gate charge total (10 V) 28 34 3.9 3.9 3.9 3.9 3.9 3.9 3.9 3.9 3.9 3.9 3.9 <t< td=""></t<>

5.2 Thermal Information

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

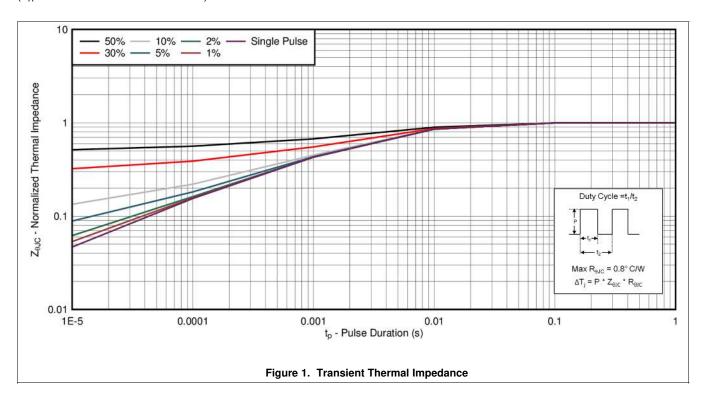
	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-case thermal resistance			8.0	°C/W
R_{\thetaJA}	Junction-to-ambient thermal resistance			62	°C/W

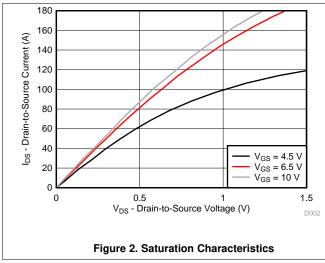
Product Folder Links: CSD18533KCS

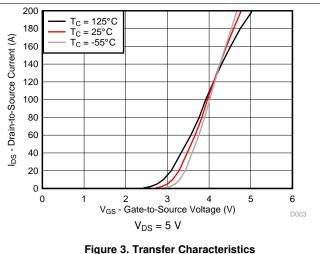


5.3 Typical MOSFET Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$







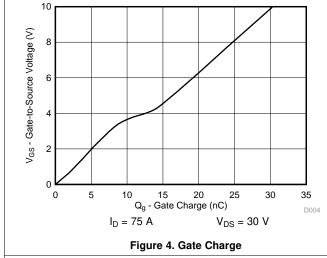
Submit Documentation Feedback

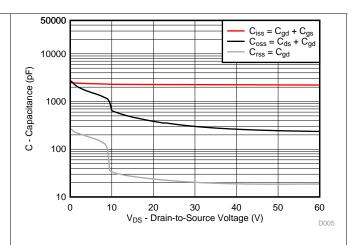
Copyright © 2012–2015, Texas Instruments Incorporated



Typical MOSFET Characteristics (continued)

(T_A = 25°C unless otherwise stated)





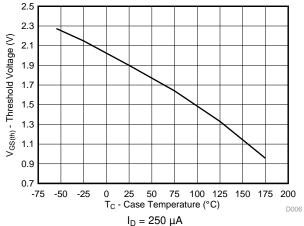


Figure 5. Capacitance

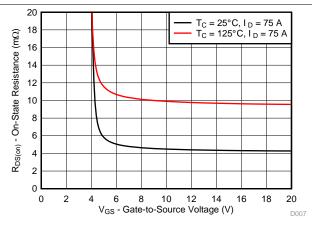


Figure 6. Threshold Voltage vs Temperature

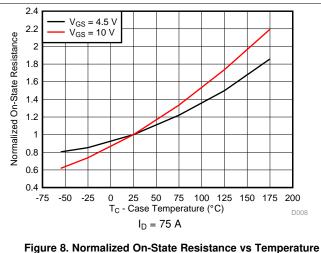


Figure 7. On-State Resistance vs Gate-to-Source Voltage

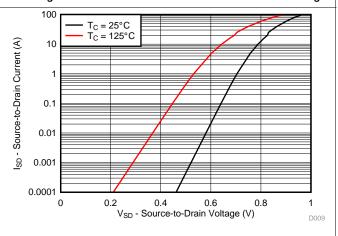
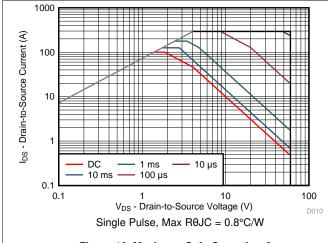


Figure 9. Typical Diode Forward Voltage



Typical MOSFET Characteristics (continued)

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$



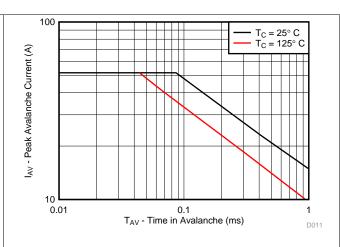


Figure 10. Maximum Safe Operating Area

Figure 11. Single Pulse Unclamped Inductive Switching

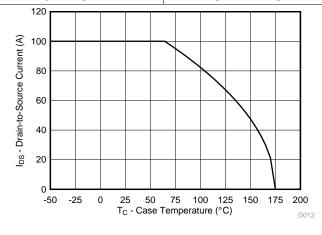


Figure 12. Maximum Drain Current vs Temperature



6 Device and Documentation Support

6.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Lise

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

6.2 Trademarks

NexFET, E2E are trademarks of Texas Instruments. All other trademarks are the property of their respective owners.

6.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

6.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

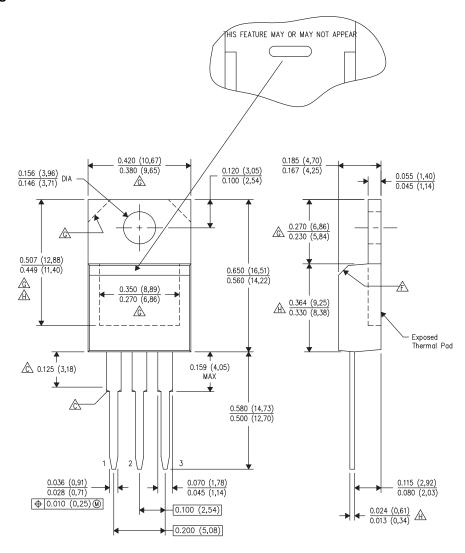
Product Folder Links: CSD18533KCS



Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

7.1 KCS Package Dimensions



- A. All linear dimensions are in inches (millimeters).
- This drawing is subject to change without notice.
- Lead dimensions are not controlled within this area. Chamfer may or may not appear
- All lead dimensions apply before solder dip.

 The center lead is in electrical contact with the mounting tab.
- The chamfer is optional.
- Thermal pad contour optional within these dimensions.
- A Falls within JEDEC TO-220 variation AB, except minimum lead thickness, minimum exposed pad length,

Pin Configuration

Position	Designation
Pin 1	Gate
Pin 2 / Tab	Drain
Pin 3	Source



PACKAGE OPTION ADDENDUM

10-Dec-2020

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CSD18533KCS	ACTIVE	TO-220	KCS	3	50	RoHS-Exempt & Green	SN	N / A for Pkg Type	-55 to 175	CSD18533KCS	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

www.ti.com 5-Jan-2022

TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CSD18533KCS	KCS	TO-220	3	50	532	34.1	700	9.6
CSD18533KCS	KCS	TO-220	3	50	532	34.1	700	9.6

IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2022, Texas Instruments Incorporated